

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination BEDNASZ ET AL.	
		Examiner Yuwen Pan	Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,825,331	10-1998	Lee, Ae-Kyoung	343/703
*	B	US-7,286,961	10-2007	Kildal, Per-Simon	702/182
*	C	US-6,329,953	12-2001	McKivergan, Patrick D.	343/703
*	D	US-7,035,594	04-2006	Wallace et al.	455/67.12
*	E	US-6,795,030	09-2004	Klingler et al.	343/703
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U			
	V			
	W			
	X			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.